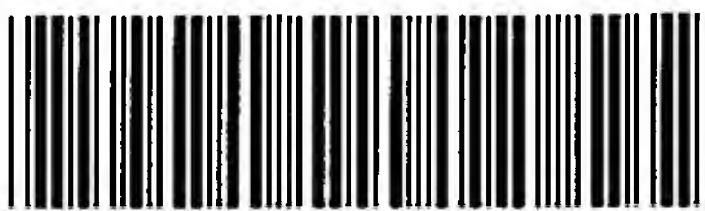


## **Search Notes**



**Application/Control No.**

10/605,930

Examiner

TAN Q. NGUYEN

**Applicant(s)/Patent under  
Reexamination**

XU ET AL.

**Art Unit**

3661

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**